



Product data sheet

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2. EMITTER

3. COLLECTOR

SOT - 23



FEATURES

- Complimentary to S8550-MS
- Collector Current: I_C=0.5A

MARKING: J3Y

MAXIMUM RATINGS (T_a=25°C unless otherwise noted)

Symbol	Parameter	Value	Unit
V _{CBO}	Collector-Base Voltage	40	V
V _{CEO}	Collector-Emitter Voltage	25	V
V _{EBO}	Emitter-Base Voltage	5	V
Ιc	Collector Current	500	mA
Pc	Collector Power Dissipation	300	mW
R _{OJA}	Thermal Resistance From Junction To Ambient	417	°C/W
T _J ,T _{stg}	Operation Junction and Storage Temperature Range	-55~+150	ĉ

ELECTRICAL CHARACTERISTICS (T₂=25℃ unless otherwise specified)

Parameter	Symbol	Test conditions	Min	Тур	Max	Unit
Collector-base breakdown voltage	V _{(BR)CBO}	I _C = 100μA, I _E =0	40			V
Collector-emitter breakdown voltage	V _{(BR)CEO}	I _C =1mA, I _B =0	25			V
Emitter-base breakdown voltage	V _{(BR)EBO}	I _E =100μΑ, I _C =0	5			V
Collector cut-off current	I _{CBO}	V _{CB} =40 V , I _E =0			0.1	μΑ
Collector cut-off current	I _{CEO}	V _{CB} =20V , I _E =0			0.1	μA
Emitter cut-off current	I _{EBO}	V _{EB} = 5V , I _C =0			0.1	μA
DC surrent asia	h _{FE(1)}	V _{CE} =1V, I _C = 50mA	120		400	
DC current gain	h _{FE(2)}	V _{CE} =1V, I _C = 500mA	50			
Collector-emitter saturation voltage	V _{CE} (sat)	Ic=500 mA, I _B = 50mA			0.6	V
Base-emitter saturation voltage	V _{BE} (sat)	I _C =500 mA, I _B = 50mA			1.2	V
Transition frequency	f _T	V _{CE} =6V, I _C = 20mA f=30MHz	150			MHz

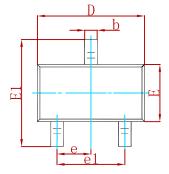
CLASSIFICATION OF hFE(1)			
Rank	L	н	J
Range	120-200	200-350	300-400

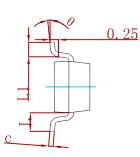
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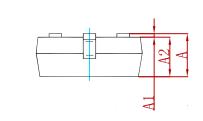




PACKAGE MECHANICAL DATA

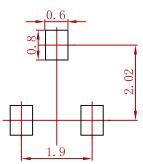






Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min	Max	Min	Max	
A	0.900	1.150	0.035	0.045	
A1	0.000	0.100	0.000	0.004	
A2	0.900	1.050	0.035	0.041	
b	0.300	0.500	0.012	0.020	
С	0.080	0.150	0.003	0.006	
D	2.800	3.000	0.110	0.118	
E	1.200	1.400	0.047	0.055	
E1	2.250	2.550	0.089	0.100	
е	0.950 TYP		0.037 TYP		
e1	1.800	2.000	0.071	0.079	
L	0.550 REF		0.022 REF		
L1	0.300	0.500	0.012	0.020	
θ	0°	8°	0°	8°	

Suggested Pad Layout



Note:

Controlling dimension:in millimeters.
General tolerance:± 0.05mm.
The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
S8050-MS	SOT-23	3000





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